



200.F PTOP4 E C. U.S. DEPARTMI PATENT AND TH						T OF COMMERCE DEMARK OFFICE		ATTY. DOCKET NO. MI22-1035			SERIAL NO. 09/234,233			
PATENT AND TRADEMARK OFFICE  OF ART CITED BY APPLICANT  (Use several sheets if necessary)								APPLICANT Weimin Li						
APR 2 8 ZOUG EST (OSCIOLA SILCOS A LOCASAS)							FILING DATE GI			GROU 2818	GROUP 2818			
U.S. PATENT DOCUMENTS						rs								
*Examiner Initial		Document Number		Date		Name			Class	Subclass		Filing Date If Appropriate		
ÞV	, AA	5,986,318		11/1999	Kim et al						_			
DV	AB	6,087,06	54	06/2000	Lin et al									
	AC													
	AD													
	AE													
	AF													
	AG													
	AH										٠			
	AI													
	AJ		•											
	AK													
	AL													
		1			FOREIGN I	PATENT DOCUME	ENT	TS .		Г				
		Document Number		Date		Country			Class	Subclass	class	Trans Yes	lation No	
	AM					•								
	AN	-								_				
	AO	<u>ll</u>	Ω1	unce seeese.	CES (includ	ling Author Title D	ate.	Pertinent Pages, Etc.)						
	Γ.,,			Hir Kin and	CLM (man-	ung rumor,, _	aw	Termon Lago, 200,						
	AP				3.1									
								····						
	AQ	$\dashv$												
		$\dashv$				·								
	AR													
				<u> </u>										
EXAMINER Gruland						DATE CONSIDERED 05/27/03								
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.														

200 romp 10.	P. E	7	د	U.S. DE	PARTMENT OF COMMERCE CAND TRADEMARK OFFICE	ATTY. DOCKET NO MI22-1035	).	SERI 09/23	AL NO. 4,233			
IAN 1	4 2000	LUST OF	ART CITED	BY APPLICA	APPLICANT Weimin Li							
(Use several sheets if necessary)							GRO 2818					
U.S. PATENT DOCUMENTS												
*Examiner Initial				Date	Name	Class	Subclass	Filing Date If Appropriate				
DV	AA	4,940,509		07/1990	Tso et al							
	AB	5,429,987		07/1995	Allen							
	AC	4,910,160		•		<del></del>						
	AD	6,200,835		03/2001	·Manning		-	<del></del>				
DV	ΑE	5,244,537		09/1993	Ohnstein		<u> </u>					
	AF								د			
	AG							-				
	АН						*	1.05				
	AI							- 5				
	AJ											
	AK											
	AL											
		1		T	FOREIGN PATENT DOCUMEN	TS		Γ	1			
		Document Number		Date	Country		Class	Subclass	Trans Yes	ation No		
	AM											
	AN											
	AO	Л		THER REFEREN	ICES (including Author, Title, Date	Pertinent Pages, Etc.)	l	<u>                                     </u>				
					, ,	<u> </u>						
	AP											
	AQ		•	-								
					-							
	AR								·			
EXAMINER	INER Shiland 05/27/03											
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.												